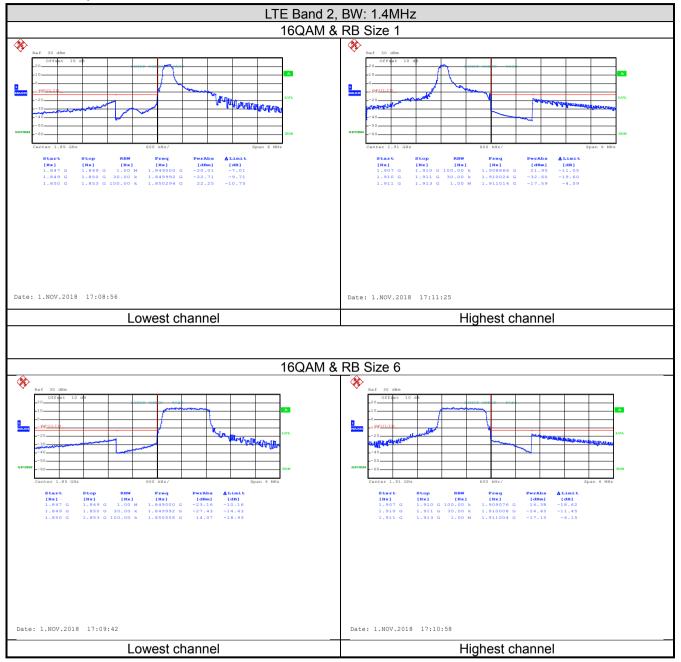






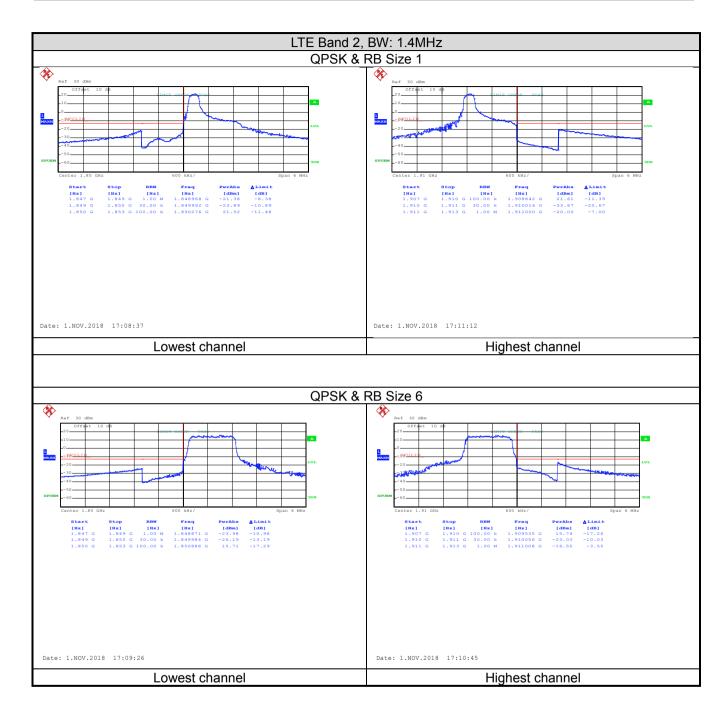
Band edge emission:

LTE Band 2 part:



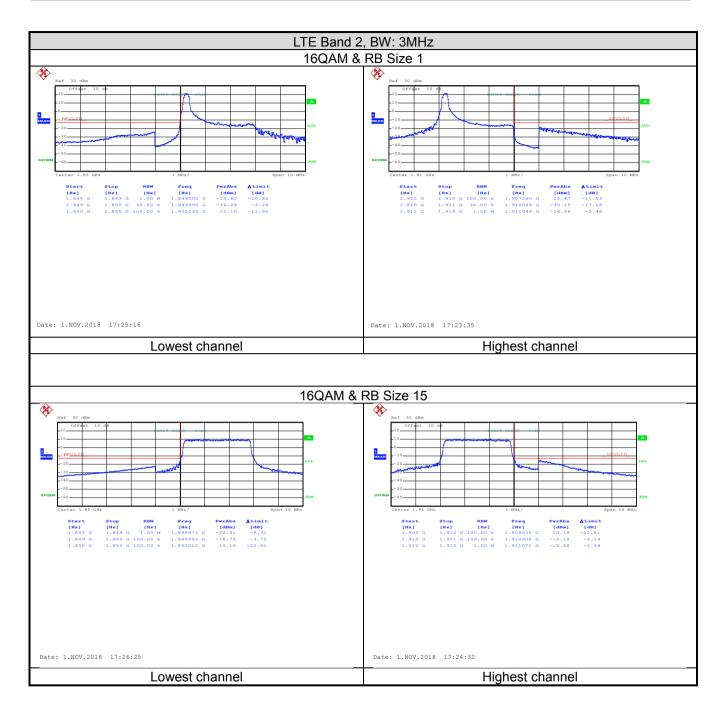






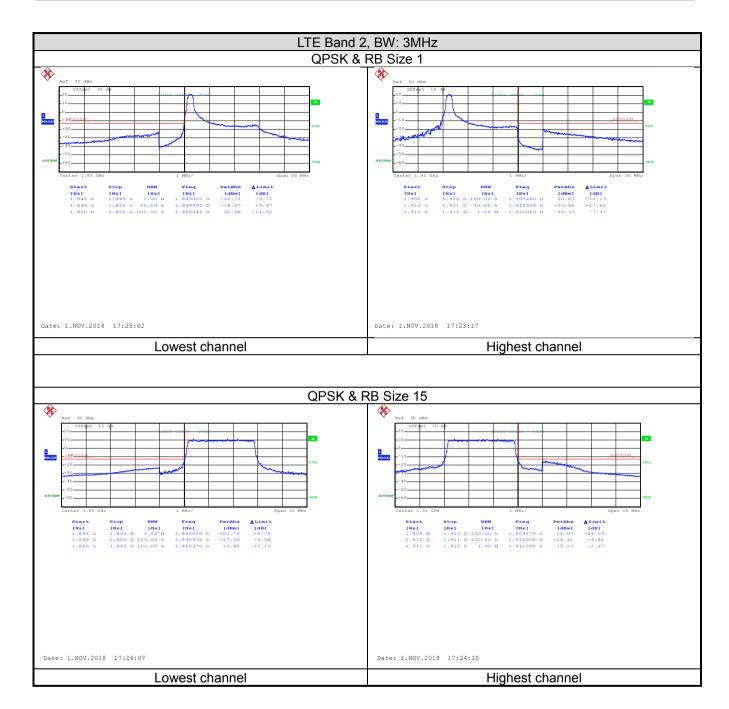






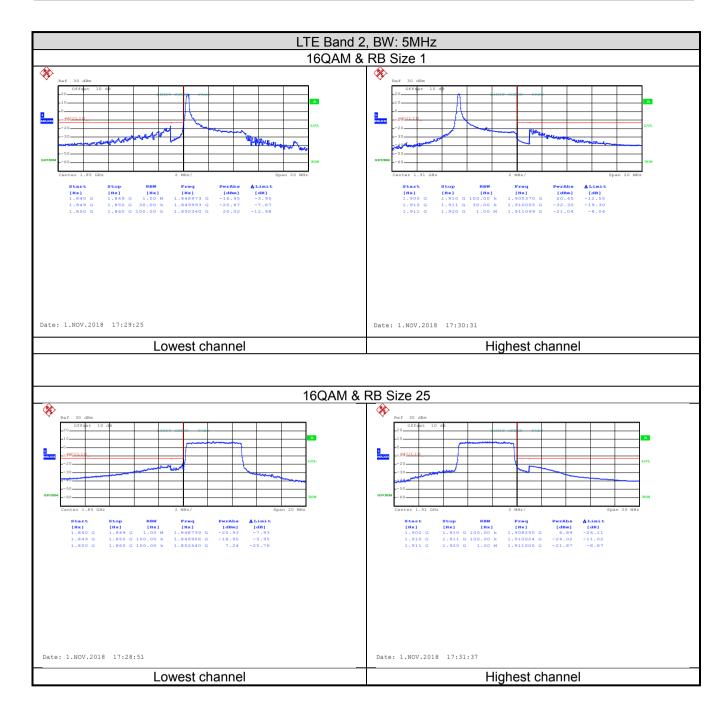






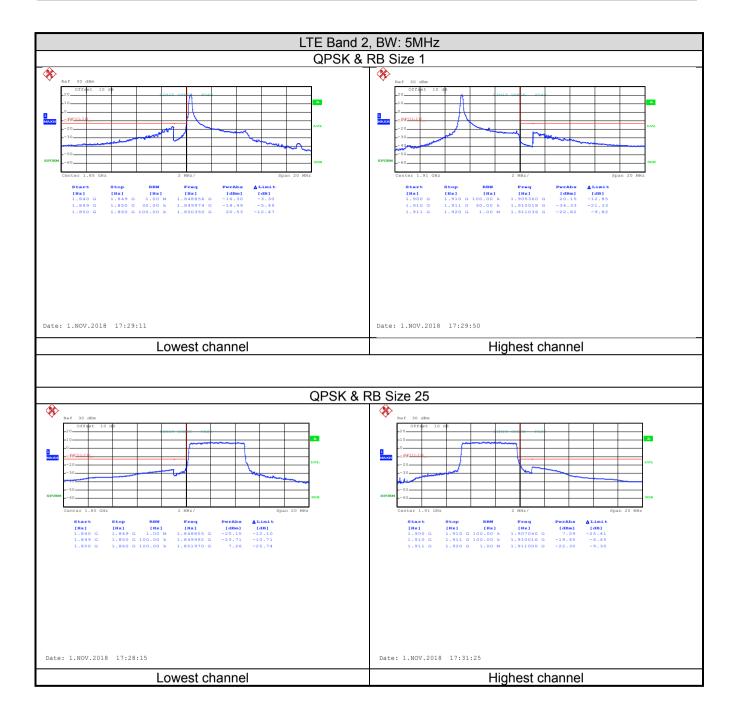






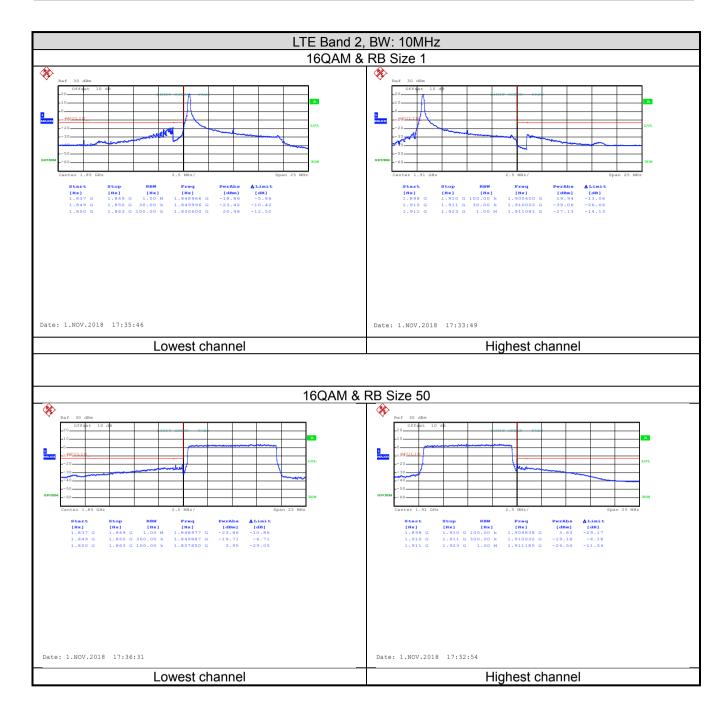






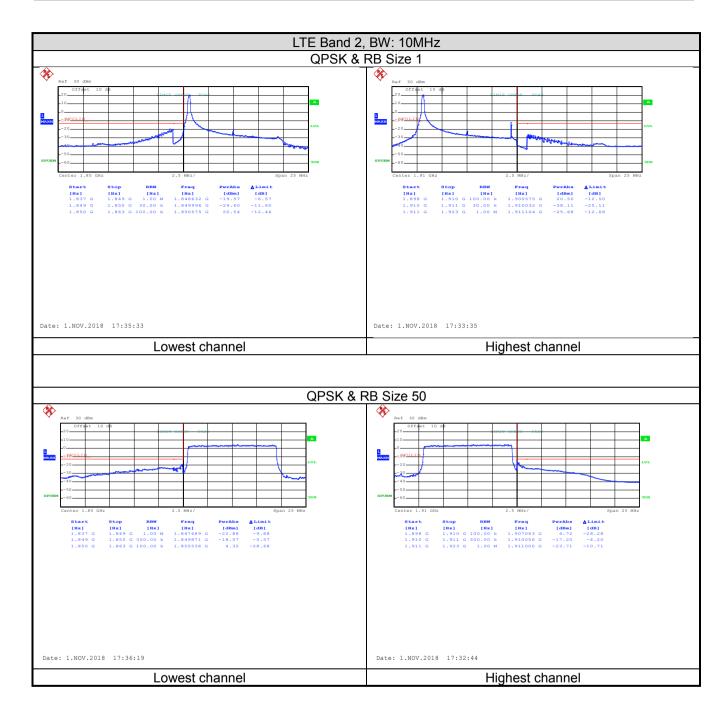






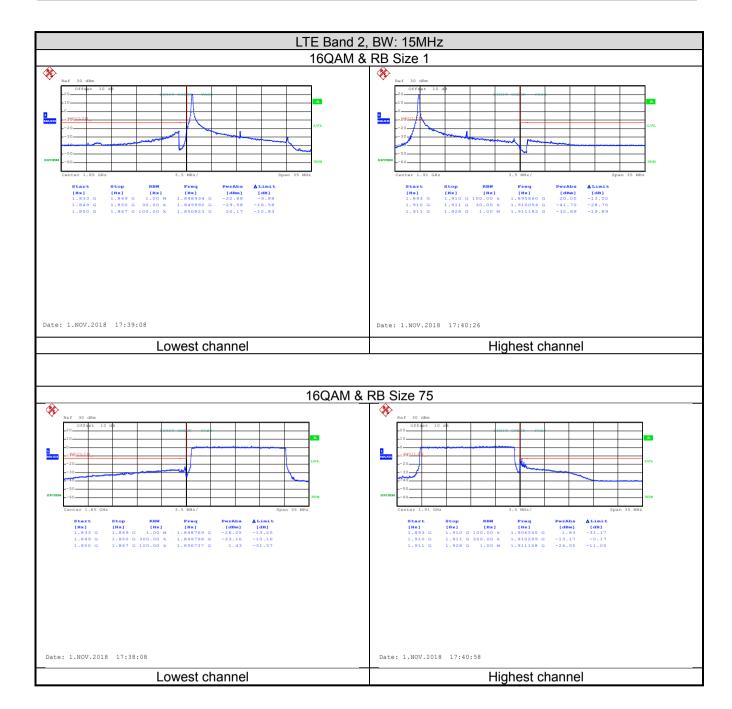






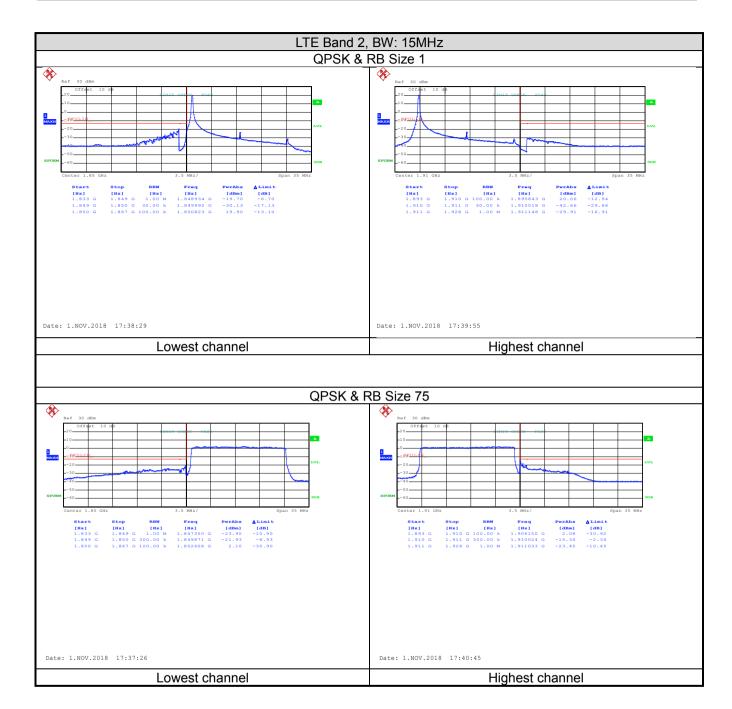






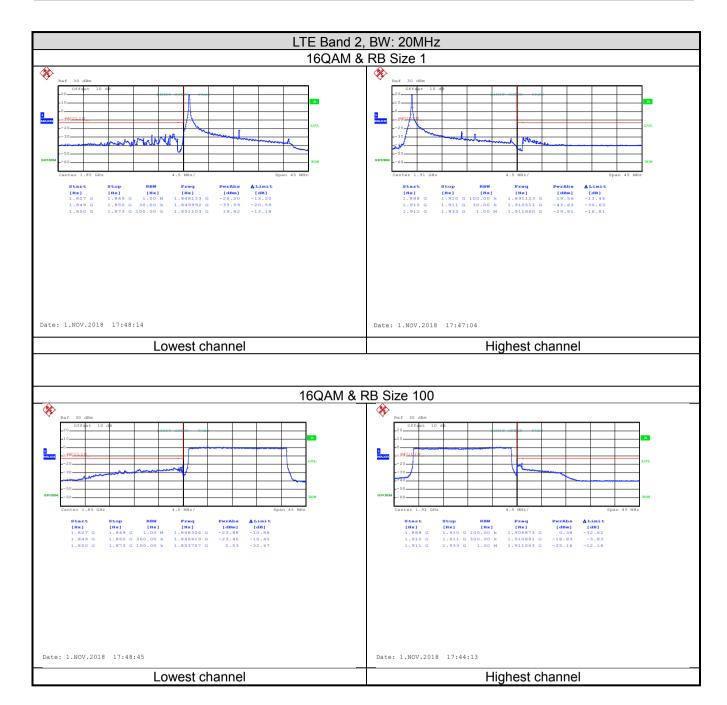






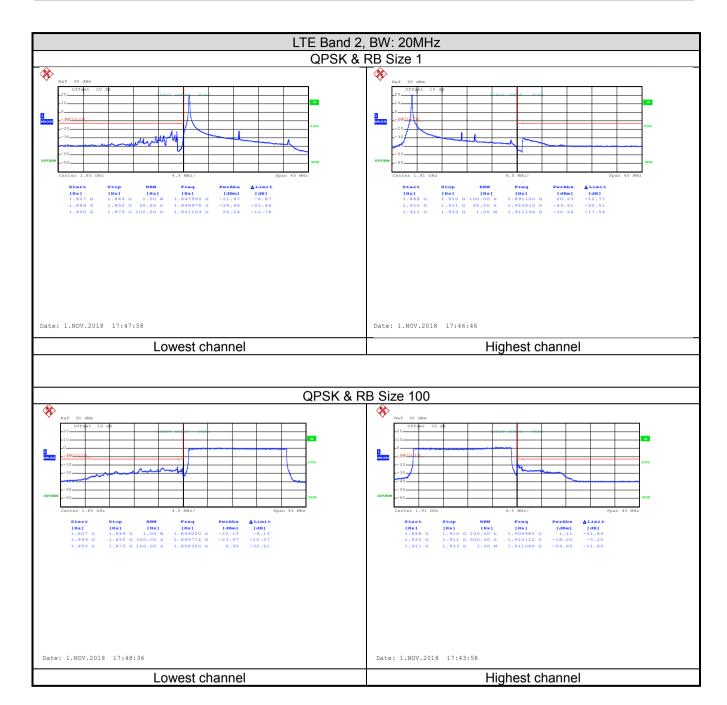








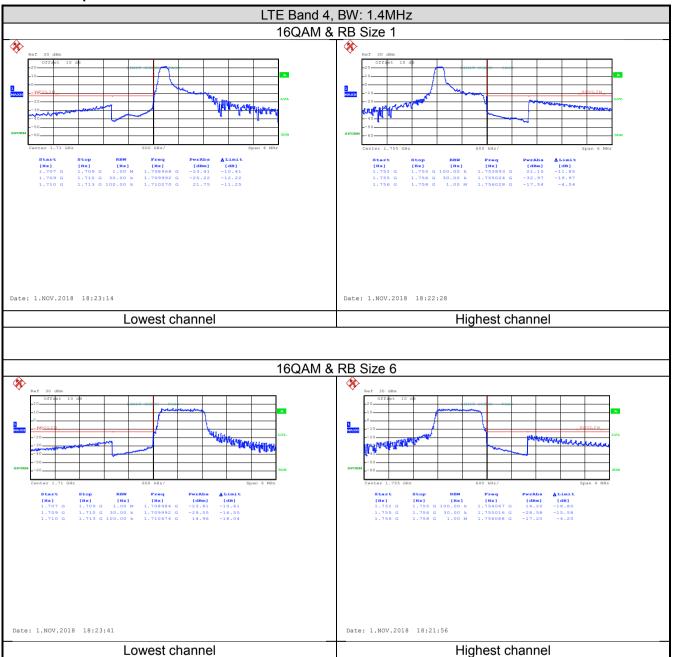






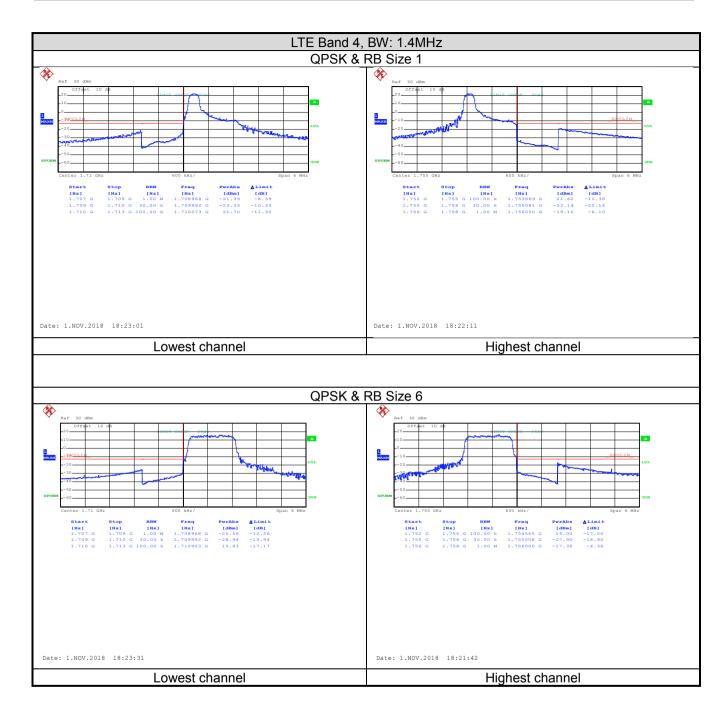


LTE Band 4 part:



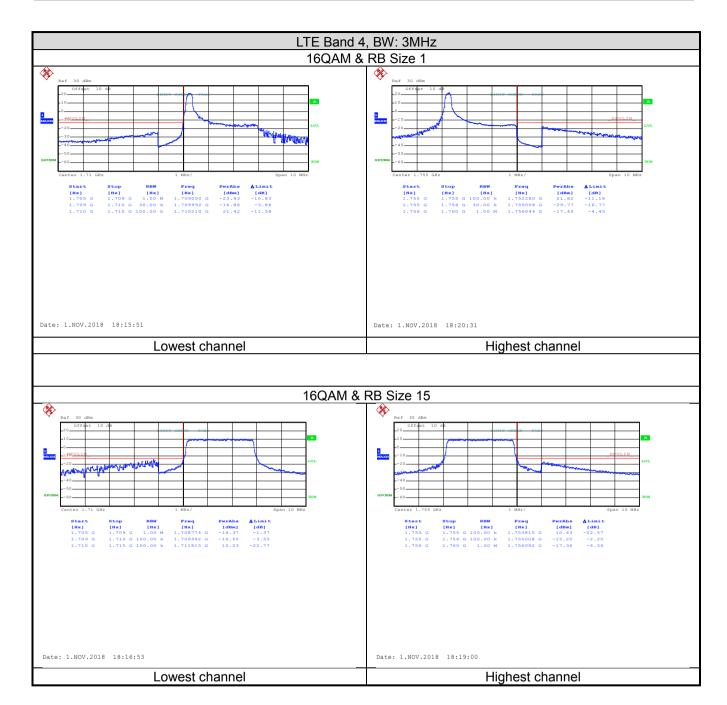






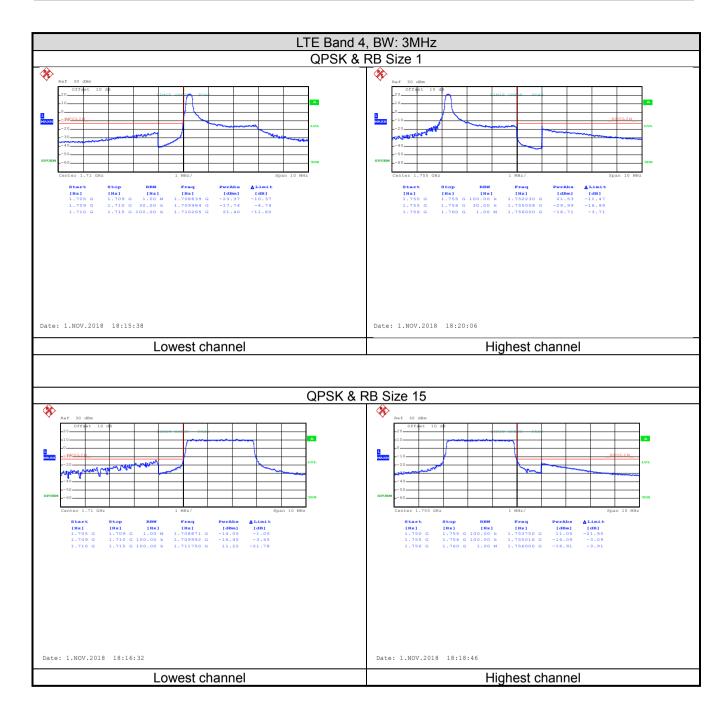






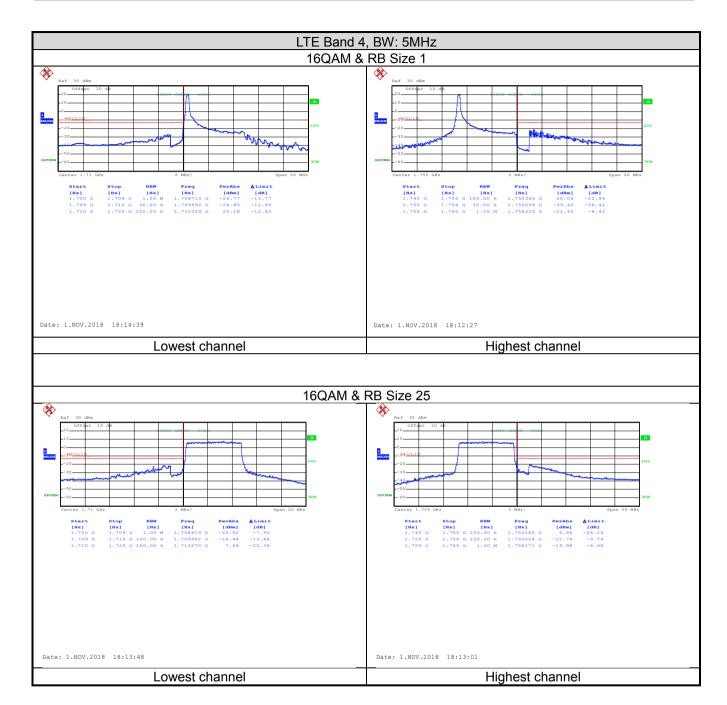






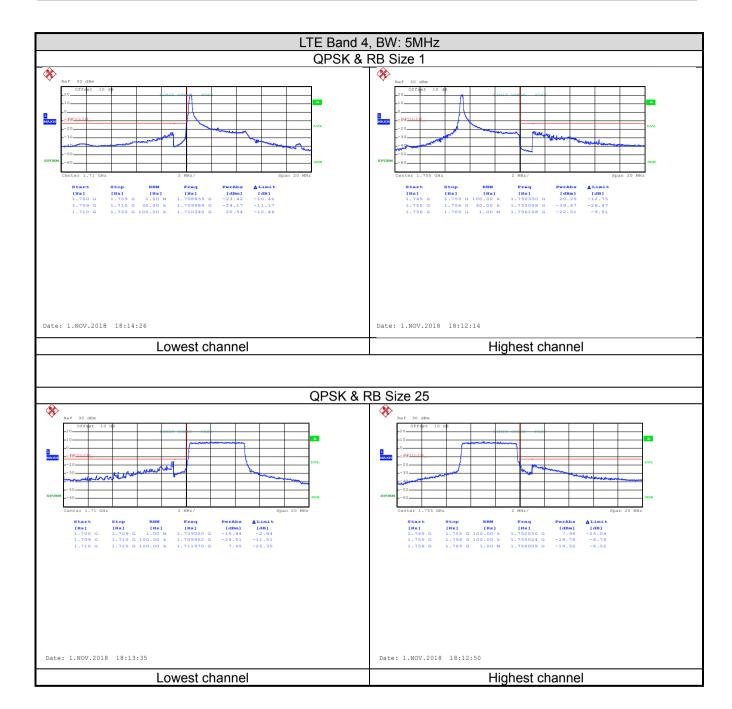






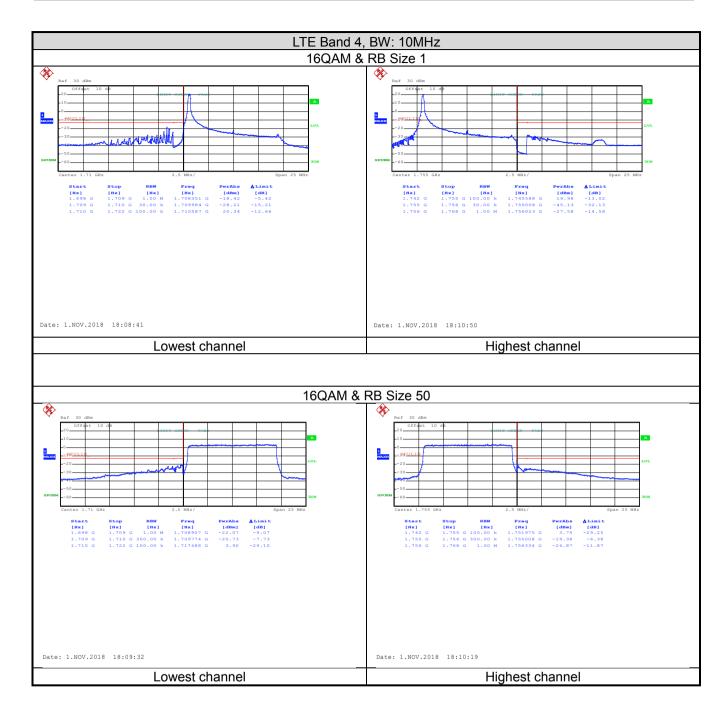






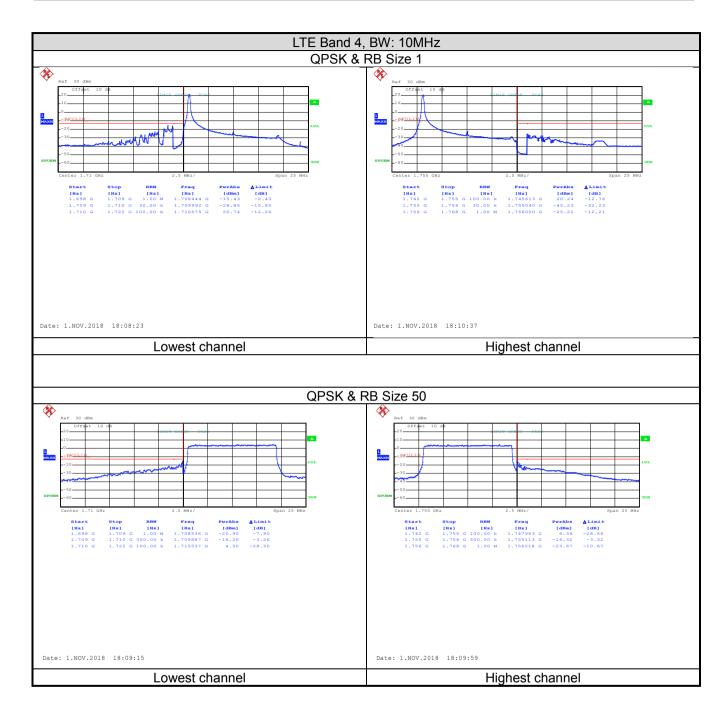






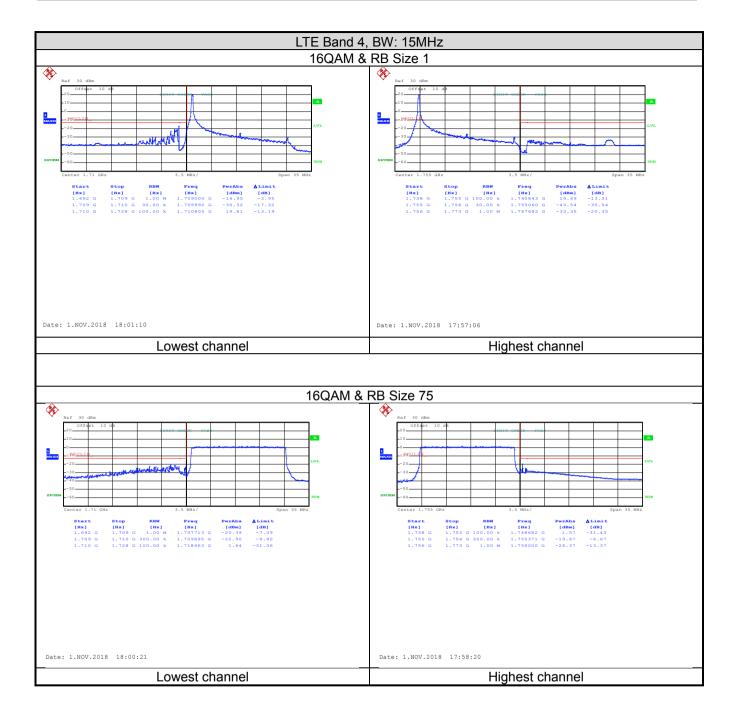






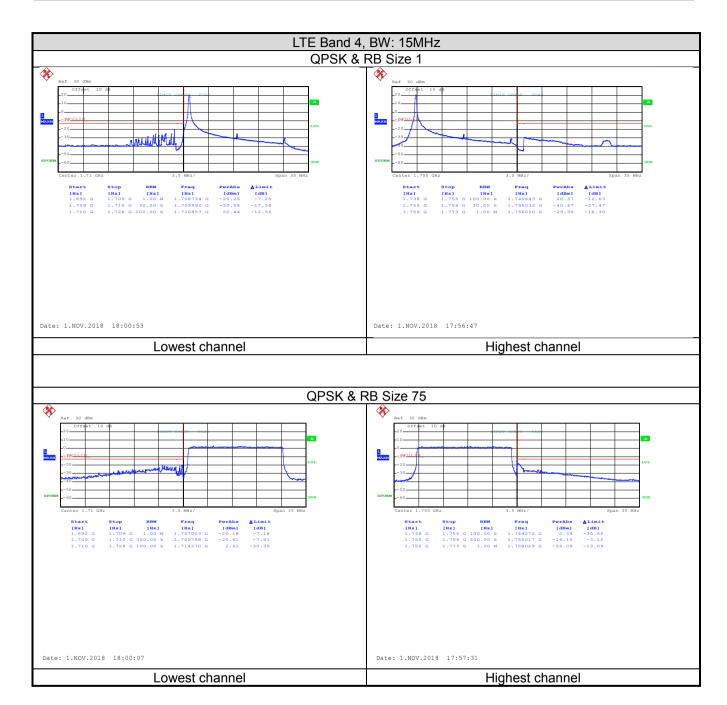






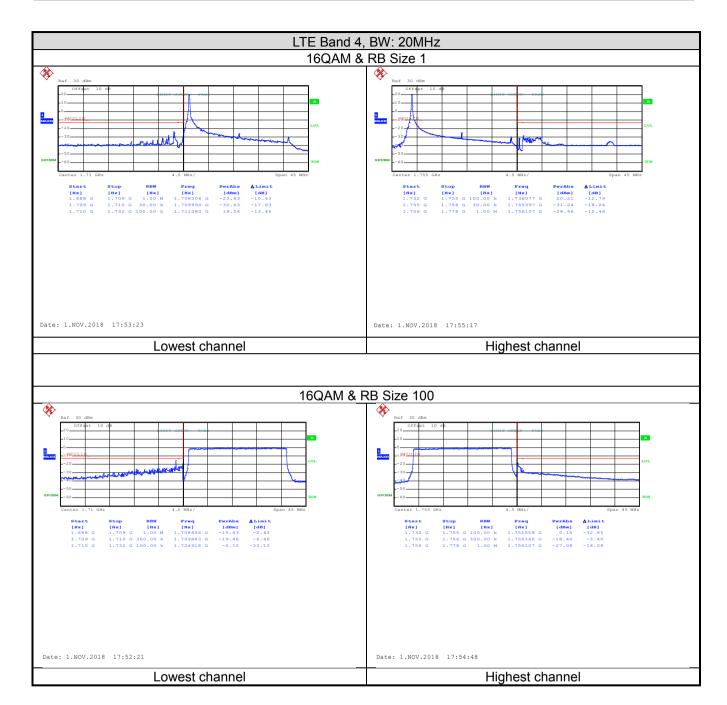






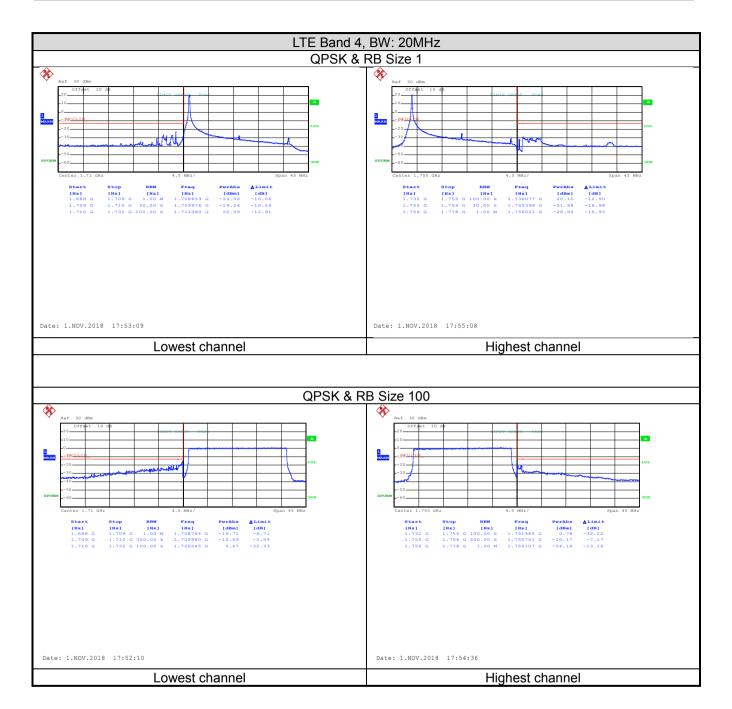








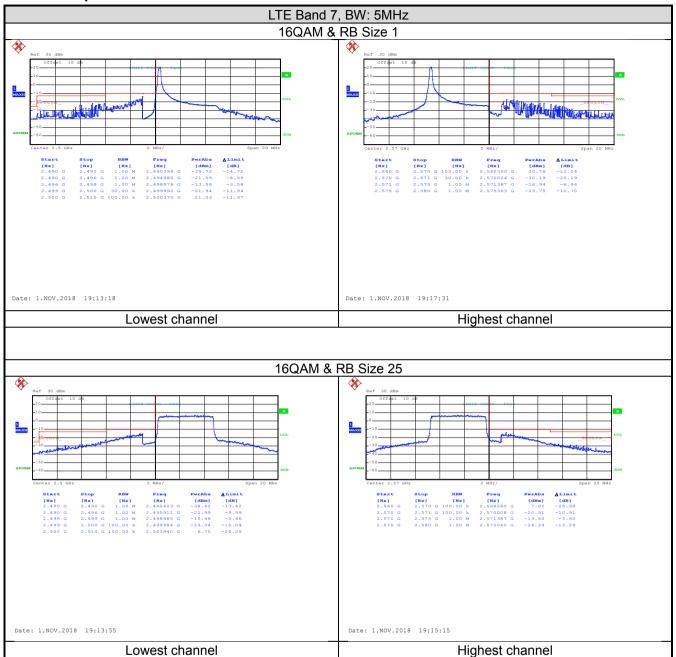






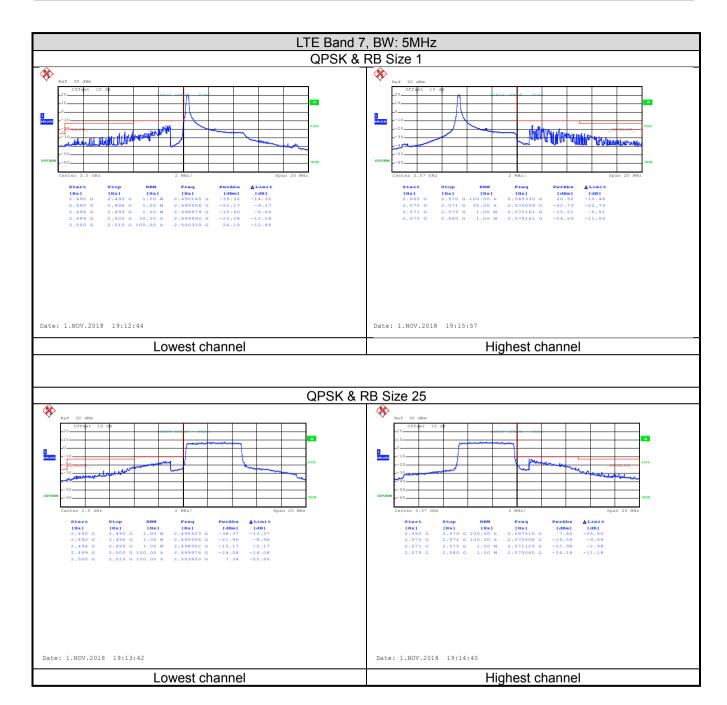


LTE Band 7 part:



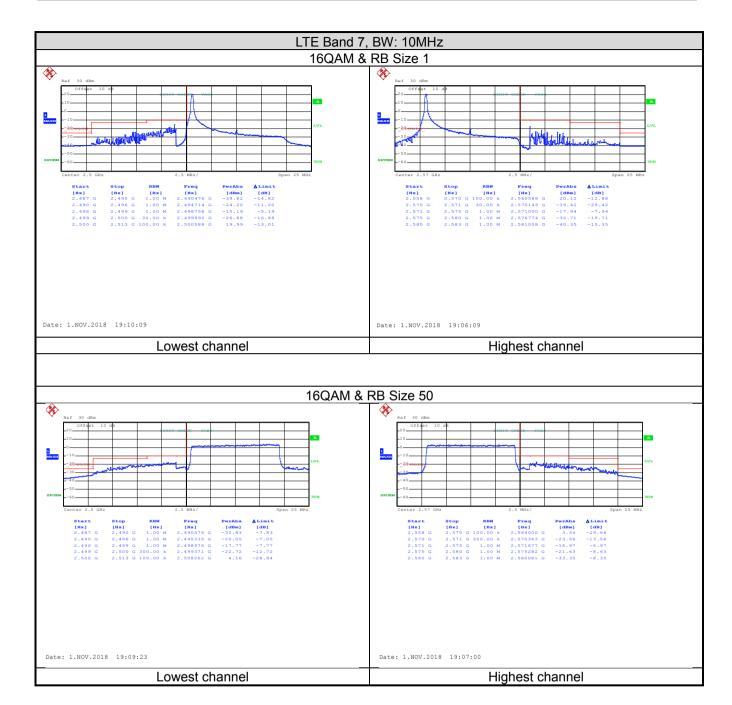






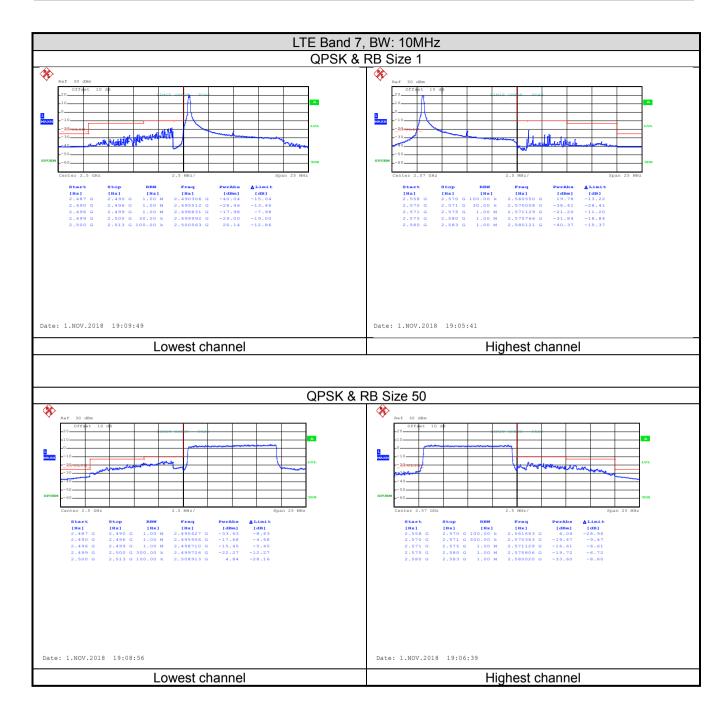






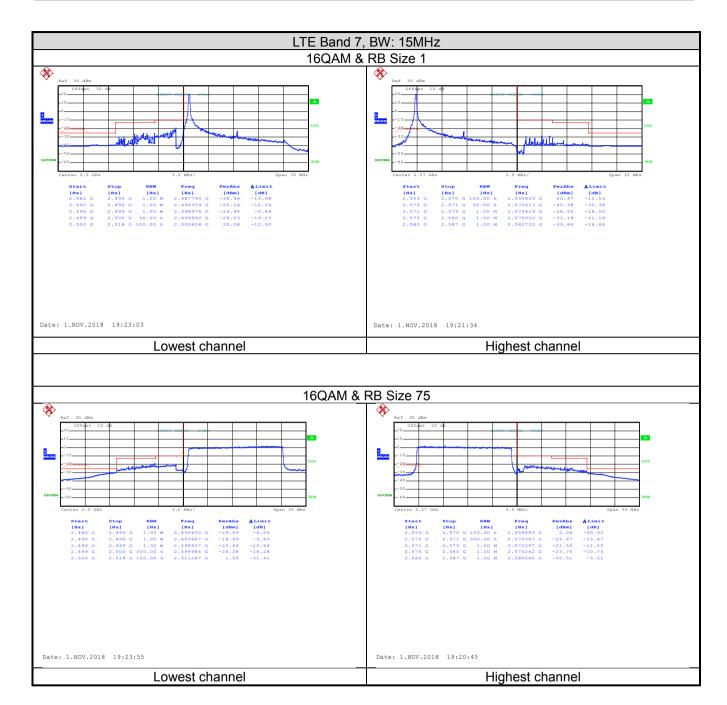






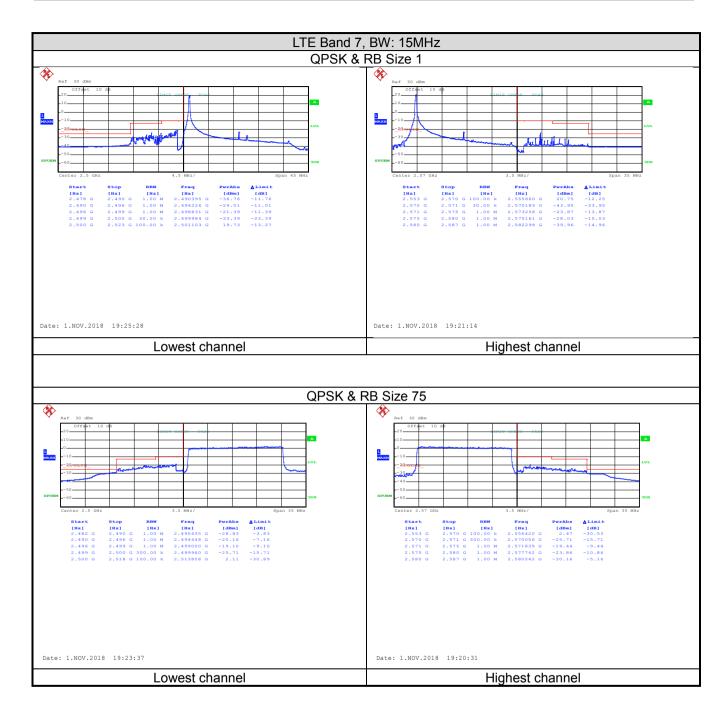






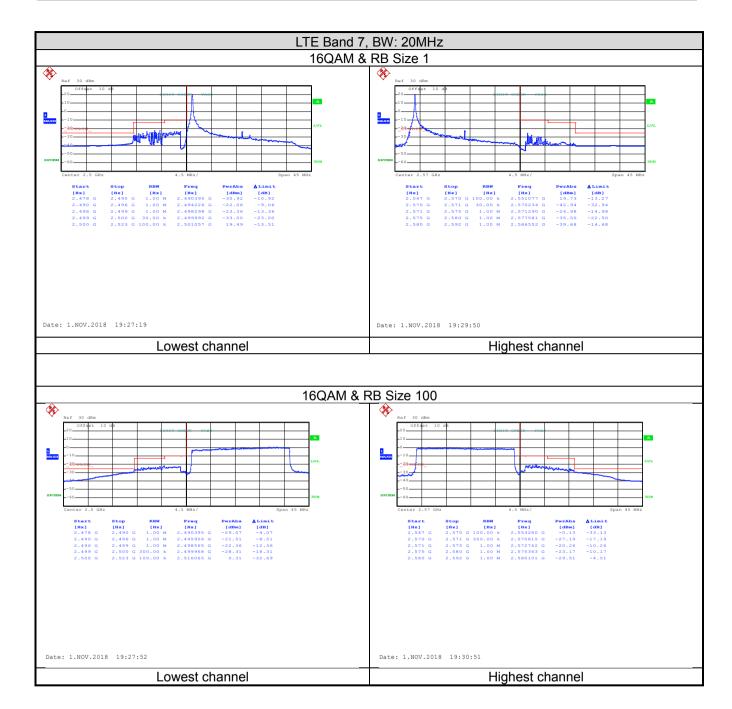






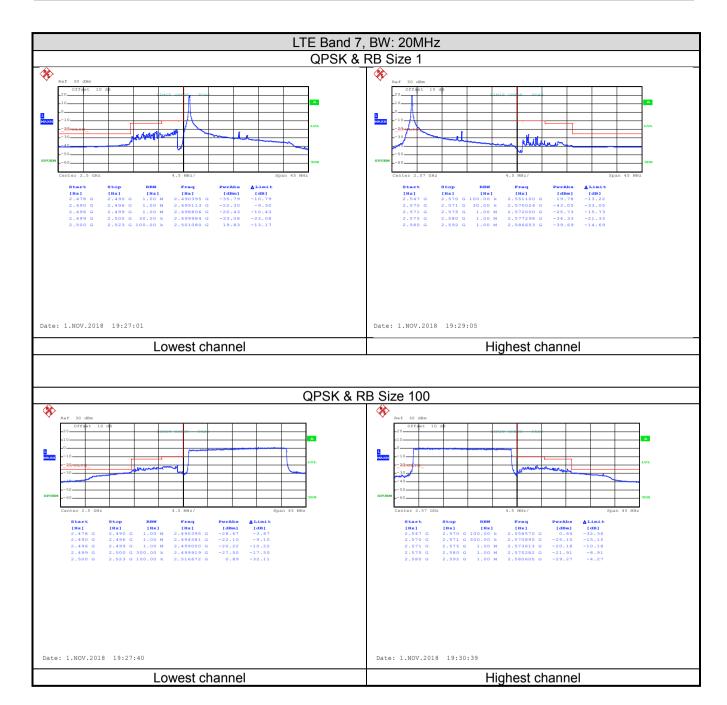














6.5 Field strength of spurious radiation measurement

	urious radiation measurement
Test Requirement:	Part 24.238 (a), Part 27.53(m), Part 27.53(h)
Test Method:	ANSI/TIA-603-D 2010
Limit:	LTE Band 2 & 4: The power of any emission outside a licensee's frequency block shall be attenuated below the transmitter power (P) in watts by at least 43 + 10 log ₁₀ (P) dB (-13 dBm). LTE Band 7: For mobile digital stations, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less that 43 + 10 log (P) dB on all frequencies between 2490.5 MHz and 2496 MHz and 55 + 10 log (P) dB at or below 2490.5 MHz.
Test setup:	Below 1GHz
	Antenna Tower Test Receiver Test Receiver Test Receiver Test Receiver
	Horn Antenna Tower Ground Reference Plane Test Receiver Test Receiver Controller
Test Procedure:	 The EUT was placed on an non-conductive turntable using a non-conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI spectrum analyzer. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations. The frequency range up to tenth harmonic was investigated for each





	of three fundamental frequency (low, middle and high channels). Once spurious emission was identified, the power of the emission was determined using the substitution method. 4. The spurious emissions attenuation was calculated as the difference between radiated power at the fundamental frequency and the spurious emissions frequency. ERP / EIRP = S.G. output (dBm) + Antenna Gain(dB/dBi) - Cable Loss (dB)
Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details.
Test results:	Passed

Measurement Data:

LTE Band 2 part:

	LT	E Band 2, WB: 1.4MI	-lz	
	RI	B size 1 & RB offset	0	
[regues 2 / MII-)	Spurious	Emission	Limit (dBm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Lilliit (dbill)	Result
		Lowest Channel		
3701.40	Vertical	-40.99		
5552.10	V	-39.18		
7402.00	V	-34.55	-13.00	Pass
3701.40	Horizontal	-43.22	-13.00	F455
5552.10	Н	-40.59		
7402.00	Н	-35.26		
		Middle Channel		
3760.00	Vertical	-40.51		Pass
5640.00	V	-41.89		
7520.00	V	-36.37	-13.00	
3760.00	Horizontal	-39.38	-13.00	
5640.00	Н	-42.13		
7520.00	Н	-36.51		
		Highest Channel		
3816.60	Vertical	-39.24		
5724.90	V	-40.31	-13.00	
7633.20	V	-34.98		Door
3816.60	Horizontal	-47.25		Pass
5724.90	Н	-44.32		
7633.20	Н	-38.90		

Note:

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





	LTE Band 2, WB: 3MHz				
	R	B size 1 & RB offset (0		
Fraguency (MHz)	Spurious	Emission	Limit (dBm)	Result	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dbin)	Result	
		Lowest Channel			
3703.00	Vertical	-40.15			
5554.50	V	-39.52			
7406.00	V	-34.71	-13.00	Door	
3703.00	Horizontal	-43.11	-13.00	Pass	
5554.50	Н	-40.52			
7406.00	Н	-35.89			
		Middle Channel			
3760.00	Vertical	-40.52		Pass	
5640.00	V	-41.51			
7520.00	V	-36.71	42.00		
3760.00	Horizontal	-39.45	-13.00		
5640.00	Н	-42.83			
7520.00	Н	-36.17			
		Highest Channel			
3817.00	Vertical	-39.85			
5725.50	V	-40.79			
7634.00	V	-34.13	-13.00	Dana	
3817.00	Horizontal	-47.51		Pass	
5725.50	Н	-44.13			
7634.00	Н	-38.58			

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





LTE Band 2, WB: 5MHz							
	R	B size 1 & RB offset (0				
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result			
Frequency (MHZ)	Polarization	Level (dBm)	Liffiit (ubifi)	Result			
	Lowest Channel						
3705.00	Vertical	-40.13					
5557.50	V	-39.25					
7410.00	V	-34.92	-13.00	Door			
3705.00	Horizontal	-43.15	-13.00	Pass			
5557.50	Н	-40.38					
7410.00	Н	-35.87					
		Middle Channel					
3760.00	Vertical	-40.36		Pass			
5640.00	V	-41.15					
7520.00	V	-36.92	-13.00				
3760.00	Horizontal	-39.73	-13.00				
5640.00	Н	-42.51					
7520.00	Н	-36.19					
		Highest Channel					
3815.00	Vertical	-39.85					
5722.50	V	-40.37					
7630.00	V	-34.14	-13.00	Pass			
3815.00	Horizontal	-47.52		Pass			
5722.50	Н	-44.18					
7630.00	Н	-38.49					

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





LTE Band 2, WB: 10MHz							
	R	B size 1 & RB offset ()				
Fraguency (MUz)	Spurious	Emission	Limit (dBm)	Result			
Frequency (MHz)	Polarization	Level (dBm)	Limit (dbin)	Result			
	Lowest Channel						
3710.00	Vertical	-40.95					
5565.00	V	-39.74					
7420.00	V	-34.51	-13.00	Pass			
3710.00	Horizontal	-43.59	-13.00	Pass			
5565.00	Н	-40.92					
7420.00	Н	-35.83					
		Middle Channel					
3760.00	Vertical	-40.85		Pass			
5640.00	V	-41.41					
7520.00	V	-36.18	-13.00				
3760.00	Horizontal	-39.97	-13.00	Pass			
5640.00	Н	-42.45					
7520.00	Н	-36.18					
		Highest Channel					
3810.00	Vertical	-39.47					
5715.00	V	-40.52					
7620.00	V	-34.19	-13.00	Door			
3810.00	Horizontal	-47.93		Pass			
5715.00	Н	-44.79					
7620.00	Н	-38.14					

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





	Lī	E Band 2, WB: 15MH	z	
	R	B size 1 & RB offset (0	
F (MILL)	Spurious	Emission	Limit (dDm)	Dogult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
		Lowest Channel		
3715.00	Vertical	-40.23		
5572.50	V	-39.92		
7430.00	V	-34.74	-13.00	Pass
3715.00	Horizontal	-43.52	-13.00	Pass
5572.50	Н	-40.89		
7430.00	Н	-35.19		
		Middle Channel		
3760.00	Vertical	-40.29		Pass
5640.00	V	-41.73		
7520.00	V	-36.41	12.00	
3760.00	Horizontal	-39.53	-13.00	Pass
5640.00	Н	-42.79		
7520.00	Н	-36.58		
		Highest Channel		
3805.00	Vertical	-39.79		
5707.50	V	-40.27		
7610.00	V	-34.51	-13.00	Pass
3805.00	Horizontal	-47.85		Pass
5707.50	Н	-44.91		
7610.00	Н	-38.39		

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





	LTE Band 2, WB: 20MHz				
		B size 1 & RB offset (
Fraguency (MHz)	Spurious	Emission	Limit (dDm)	Result	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
		Lowest Channel			
3720.00	Vertical	-40.61			
5580.00	V	-39.63			
7440.00	V	-34.81	-13.00	Door	
3720.00	Horizontal	-43.41	-13.00	Pass	
5580.00	Н	-40.26			
7440.00	Н	-35.11			
		Middle Channel			
3760.00	Vertical	-40.13		Pass	
5640.00	V	-41.57			
7520.00	V	-36.51	42.00		
3760.00	Horizontal	-39.67	-13.00		
5640.00	Н	-42.64			
7520.00	Н	-36.24			
		Highest Channel			
3800.00	Vertical	-39.52			
5700.00	V	-40.18			
7600.00	V	-34.96	-13.00		
3800.00	Horizontal	-47.63		Pass	
5700.00	Н	-44.18			
7600.00	Н	-38.64			

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





LTE Band 4 part:

LTE Band 4, WB: 1.4MHz					
RB size 1 & RB offset 0					
Frequency (MHz)	Spurious Emission		Limit (dBm)	Result	
Frequency (Miriz)	Polarization	Level (dBm)	Lilliit (ubili)	Kesuit	
		Lowest Channel			
3421.40	Vertical	-42.62			
5132.10	V	-42.88			
6842.80	V	-37.00	-13.00	Pass	
3421.40	Horizontal	-43.29	-13.00	Pass	
5132.10	Н	-43.22			
6842.80	Н	-36.07			
		Middle Channel			
3465.00	Vertical	-45.78		Pass	
5197.50	V	-42.00			
6930.00	V	-37.13	-13.00		
3465.00	Horizontal	-47.25	-13.00		
5197.50	Н	-42.66			
6930.00	Н	-36.21			
		Highest Channel			
3508.60	Vertical	-44.95			
5262.90	V	-42.08	-13.00		
7017.20	V	-37.50		Dage	
3508.60	Horizontal	-45.73		Pass	
5262.90	Н	-42.18			
7017.20	Н	-36.53			

Note:

^{1.}

The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report. For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





LTE Band 4, WB: 3MHz							
	R	B size 1 & RB offset (0				
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result			
Frequency (MHZ)	Polarization	Level (dBm)	Limit (dbin)	Result			
	Lowest Channel						
3423.00	Vertical	-42.35					
5134.50	V	-42.18					
6846.00	V	-37.31	-13.00	Door			
3423.00	Horizontal	-43.55	-13.00	Pass			
5134.50	Н	-43.18					
6846.00	Н	-36.89					
		Middle Channel					
3465.00	Vertical	-45.18		Pass			
5197.50	V	-42.07					
6930.00	V	-37.29	40.00				
3465.00	Horizontal	-47.51	-13.00				
5197.50	Н	-42.56					
6930.00	Н	-36.69					
		Highest Channel					
3507.00	Vertical	-44.13					
5260.50	V	-42.18					
7014.00	V	-37.51	-13.00	Door			
3507.00	Horizontal	-47.52		Pass			
5260.50	Н	-42.39					
7014.00	Н	-36.49					

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





LTE Band 4, WB: 5MHz					
RB size 1 & RB offset 0					
Frequency (MHz)	Spurious	Emission	Limit (dRm)	Result	
riequency (MHZ)	Polarization	Level (dBm)	Limit (dBm)	Result	
		Lowest Channel			
3425.00	Vertical	-42.91			
5137.50	V	-42.15			
6850.00	V	-37.26	-13.00	Pass	
3425.00	Horizontal	-43.85	-13.00	Pass	
5137.50	Н	-43.71			
6850.00	Н	-38.19			
		Middle Channel			
3465.00	Vertical	-45.13		Pass	
5197.50	V	-42.92			
6930.00	V	-37.61	-13.00		
3465.00	Horizontal	-47.63	-13.00		
5197.50	Н	-42.15			
6930.00	Н	-36.85			
		Highest Channel			
3505.00	Vertical	-44.13			
5257.50	V	-42.97			
7010.00	V	-37.78	-13.00	Pass	
3505.00	Horizontal	-45.18		Fd55	
5257.50	Н	-42.93			
7010.00	Н	-36.17			

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





	Lī	E Band 4, WB: 10MH	z	
	R	B size 1 & RB offset ()	
F (MIL.)	Spurious	Emission	Limit (dPm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
		Lowest Channel		
3430.00	Vertical	-42.58		
5145.00	V	-42.79		
6860.00	V	-37.16	-13.00	Pass
3430.00	Horizontal	-43.57	-13.00	Pass
5145.00	Н	-43.80		
6860.00	Н	-36.06		
		Middle Channel		
3465.00	Vertical	-45.71		Pass
5197.50	V	-42.95		
6930.00	V	-37.58	-13.00	
3465.00	Horizontal	-47.15	-13.00	Fd55
5197.50	Н	-42.31		
6930.00	Н	-36.29		
		Highest Channel		
3500.00	Vertical	-44.57		
5250.00	V	-42.82		
7000.00	V	-37.49	-13.00	Pass
3500.00	Horizontal	-47.31		Pass
5250.00	Н	-42.55		
7000.00	Н	-36.79		

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





LTE Band 4, WB: 15MHz					
	RI	B size 1 & RB offset ()		
Frequency (MHz)	Spurious I	Emission	Limit (dRm)	Result	
Frequency (MHZ)	Polarization	Level (dBm)	Limit (dBm)	Result	
		Lowest Channel			
3435.00	Vertical	-42.25			
5152.50	V	-42.52			
6870.00	V	-37.56	-13.00	Pass	
3435.00	Horizontal	-43.17	-13.00	Pass	
5152.50	Н	-43.55			
6870.00	Н	-38.95			
		Middle Channel			
3465.00	Vertical	-45.85			
5197.50	V	-42.47			
6930.00	V	-37.15	-13.00	Pass	
3465.00	Horizontal	-47.88	-13.00	Fa55	
5197.50	Н	-42.61			
6930.00	Н	-36.19			
		Highest Channel			
3495.00	Vertical	-44.85			
5242.50	V	-42.13			
6990.00	V	-37.51	-13.00	Pass	
3495.00	Horizontal	-45.89	-13.00	Pass	
5242.50	Н	-42.33			
6990.00	Н	-36.81			

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





LTE Band 4, WB: 20MHz						
	RI	B size 1 & RB offset ()			
Frequency (MHz)	Spurious	Emission	Limit (dPm)	Result		
riequency (MHZ)	Polarization	Level (dBm)	Limit (dBm)	Result		
		Lowest Channel				
3440.00	Vertical	-42.29				
5160.00	V	-42.00				
6880.00	V	-37.85	-13.00	Pass		
3440.00	Horizontal	-43.18	-13.00	Fa55		
5160.00	Н	-43.93				
6880.00	Н	-36.80				
Middle Channel						
3465.00	Vertical	-45.27				
5197.50	V	-42.19				
6930.00	V	-37.29	-13.00	Pass		
3465.00	Horizontal	-47.82	-13.00	F455		
5197.50	Н	-42.19				
6930.00	Н	-36.79				
		Highest Channel				
3490.00	Vertical	-44.83				
5235.00	V	-42.97				
6980.00	V	-37.49	-13.00	Pass		
3490.00	Horizontal	-47.59	-13.00	F d >>		
5235.00	Н	-42.17				
6980.00	Н	-36.93				

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





LTE Band 7 part:

	Ľ	TE Band 7, WB: 5MHz	2	
	R	B size 1 & RB offset 0)	
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
Frequency (MHZ)	Polarization	Level (dBm)	LIIIII (UDIII)	Result
		Lowest Channel		
5005.00	Vertical	-33.15		
7507.50	V	-30.82		
10010.00	V -32.71 Horizontal -33.89		25.00	Door
5005.00			-25.00	Pass
7507.50	Н	-32.63		
10010.00	Н	-34.75		
		Middle Channel		
5070.00	Vertical	-32.18		
7605.00	V	-30.17		
10140.00	V	-32.52	05.00	Dana
5070.00	Horizontal	-35.08	-25.00	Pass
7605.00	Н	-40.25		
10140.00	Н	-36.61		
		Highest Channel		
5135.00	Vertical	-32.06		
7702.50	V	-31.01		
10270.00	V	-31.83	05.00	Dana
5135.00	Horizontal	-32.83	-25.00	Pass
7702.50	Н	-29.94		
10270.00	Н	-33.15		

Note:

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





LTE Band 7, WB: 10MHz						
	RI	B size 1 & RB offset ()			
Frequency (MHz)	Spurious Emission		Limit (dBm)	Result		
Frequency (MHZ)	Polarization	Level (dBm)	LIIIII (UDIII)	Result		
		Lowest Channel				
5010.00	Vertical	-33.87				
7515.00	V	-30.19				
10020.00	V	-32.46	-25.00	Pass		
5010.00	Horizontal	-33.83	-25.00	F455		
7515.00	Н	-32.49				
10020.00	Н	-34.15				
Middle Channel						
5070.00	Vertical	-32.73				
7605.00	V	-30.18				
10140.00	V	-32.51	-25.00	Pass		
5070.00	Horizontal	-35.79	-25.00	Fd55		
7605.00	Н	-40.85				
10140.00	Н	-36.19				
		Highest Channel				
5130.00	Vertical	-32.83				
7695.00	V	-31.69				
10260.00	V	-31.73	25.00	Pass		
5130.00	Horizontal	-32.18	-25.00	Pass		
7695.00	Н	-29.50				
10260.00	Н	-33.74				

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





LTE Band 7, WB: 15MHz					
	R	B size 1 & RB offset (0		
Fraguency (MHz)	Spurious Emission		Limit (dRm)	Result	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
		Lowest Channel			
5015.00	Vertical	-32.91			
7522.50	V	-30.87			
10030.00			25.00	Door	
5015.00			-25.00	Pass	
7522.50					
10030.00	Н	-34.73			
		Middle Channel			
5070.00	Vertical	-32.71			
7605.00	V	-30.18			
10140.00	V	-32.92	25.00	Dese	
5070.00	Horizontal	-35.18	-25.00	Pass	
7605.00	Н	-40.23			
10140.00	Н	-36.85			
		Highest Channel			
5125.00	Vertical	-32.19			
7687.50	V	-31.73			
10250.00	V	-31.15	25.00	Dana	
5125.00	Horizontal	-32.59	-25.00	Pass	
7687.50	Н	-29.73			
10250.00	Н	-33.74			

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





LTE Band 7, WB: 20MHz					
	R	B size 1 & RB offset (0		
Fraguency (MHz)	Spurious Emission		Limit (dDm)	Result	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
		Lowest Channel			
5020.00	Vertical	-33.17			
7530.00	V	-30.52			
10040.00			25.00	Desa	
5020.00			-25.00	Pass	
7530.00					
10040.00	Н	-34.83			
		Middle Channel			
5070.00	Vertical	-32.71			
7605.00	V	-30.28			
10140.00	V	-32.93	25.00	Desa	
5070.00	Horizontal	-35.89	-25.00	Pass	
7605.00	Н	-40.13			
10140.00	Н	-36.55			
		Highest Channel			
5120.00	Vertical	-32.91			
7680.00	V	-31.76			
10240.00	V	-31.52	25.00	Door	
5120.00	Horizontal	-32.43	-25.00	Pass	
7680.00	Н	-29.51			
10240.00	Н	-33.71			

^{1.} The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.

^{2.} For above 1 GHz, all test modes were performed, and just the worst case shown in the report.





6.6 Frequency stability V.S. Temperature measurement

Test Requirement:	Part 24.235, Part 27.54, Part 2.1055(a)(1)(b)
Test Method:	ANSI/TIA-603-D 2010
Limit:	±2.5ppm
Test setup:	SS Divider Temperature & Humidity Chamber Power Source
Test procedure:	 The equipment under test was connected to an external DC power supply and input rated voltage. RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators. The EUT was placed inside the temperature chamber. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 25°C operating frequency as reference frequency. Turn EUT off and set the chamber temperature to -30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency. Repeat step measure with 10°C increased per stage until the highest temperature of +50°C reached
Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





Measurement Data (worst case):

LTE Band 2 part:

Power supplied	requency: LTE Band 2		ency error		
(Vdc)	Temperature (°C)	Hz	ppm	Limit (ppm)	Result
		QPSK			
	-30	198	0.105319		
	-20	155	0.082447		
	-10	163	0.086702		
	0	123	0.065426		
3.80	10	188	0.100000	±2.5	Pass
	20	174	0.092553		
	30	114	0.060638		
	40	105	0.055851		
	50	150	0.079787		
	<u>, </u>	16QAM			
	-30	123	0.065426		
	-20	150	0.079787		
	-10	166	0.088298		
	0	122	0.064894		
3.80	10	144	0.076596	±2.5	Pass
	20	140	0.074468		
	30	156	0.082979		
	40	133	0.070745	_	
	50	138	0.073404		





LTE Band 4 part:

Reference Fi	requency: LTE Band 4	4 (10MHz) Midd	le channel=20175	channel=1732.5	0MHz
Power supplied	Temperature (°C)	Freque	ency error	Limit (ppm)	Result
(Vdc)	remperature (c)	Hz	ppm	Еши (ррш)	Nesuit
		QPSK			
	-30	198	0.114286		
	-20	155	0.089466		
	-10	163	0.094084		
	0	123	0.070996		
3.80	10	188	0.108514	±2.5	Pass
	20	174	0.100433]	
	30	114	0.065801		
	40	105	0.060606		
	50	150	0.086580		
		16QAM			
	-30	123	0.070996		
	-20	150	0.086580		
	-10	166	0.095815		
	0	122	0.070418		
3.80	10	144	0.083117	±2.5	Pass
	20	140	0.080808		
	30	156	0.090043		
	40	133	0.076768		
	50	138	0.079654		





LTE Band 7 part:

	quency: LTE Band 7	•		Frequency=2535.	.00MHz
Power supplied	Temperature (°C)	Freque	ency error	Limit (ppm)	Result
(Vdc)	Tomporataro (o)	Hz	ppm	Limit (ppm)	rtoodit
		QPSK			
	-30	198	0.078107		
	-20	155	0.061144		
	-10	163	0.064300		
	0	123	0.048521		
3.80	10	188	0.074162	±2.5	Pass
	20	174	0.068639		
	30	114	0.044970		
	40	105	0.041420	1	
	50	150	0.059172		
		16QAM			
	-30	123	0.048521		
	-20	150	0.059172		
	-10	166	0.065483		
	0	122	0.048126		
3.80	10	144	0.056805	±2.5	Pass
	20	140	0.055227		
	30	156	0.061538		
	40	133	0.052465		
	50	138	0.054438		





6.7 Frequency stability V.S. Voltage measurement

Test Requirement:	Part 24.235, Part 27.54, Part 2.1055(d)(2)
Test Method:	ANSI/TIA-603-D 2010
Limit:	±2.5ppm
Test setup:	SS Divider Temperature & Humidity Chamber
Test procedure:	 Set chamber temperature to 25°C. Use a variable DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency. Reduce the input voltage to specify extreme voltage variation (+/-15%) and endpoint, record the maximum frequency change.
Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed



Report No: CCISE181005105

Measurement Data (worst case):

LTE Band 2 part:

Reference Frequency: LTE Band 2(10MHz) Middle channel=18900 channel=1880.00MHz						
Tomporature (°C)	Power supplied	Frequen	cy error	Limit (nnm)	Danill	
Temperature (℃)	(Vdc)	Hz	ppm	Limit (ppm)	Result	
	QPSK					
	4.35	98	0.052128			
25	3.80	65	0.034574	±2.5	Pass	
	3.50	74	0.039362			
		16QAM				
	4.35	80	0.042553			
25	3.80	96	0.051064	±2.5	Pass	
	3.50	48	0.025532			
Note: Only the worst case	se shown in the report.	·				

LTE Band 4 part:

Reference Frequency: LTE Band 4(10MHz) Middle channel=20175 channel=1732.50MHz							
Temperature (°C)	Power supplied	Frequency error		Limit (nnm)	Dogult		
	(Vdc)	Hz	ppm	Limit (ppm)	Result		
		QPSK					
25	4.35	98	0.056566	±2.5	Pass		
	3.80	65	0.037518				
	3.50	74	0.042713				
		16QAM					
25	4.35	80	0.046176	±2.5	Pass		
	3.80	96	0.055411				
	3.50	48	0.027706				
Note: Only the worst ca	se shown in the report.						

LTE Band 7 part:

Reference Frequency: LTE Band 7(10MHz) Middle channel=21100 Frequency=2535.00MHz								
Temperature (°C)	Power supplied	Frequency error		Limit (nnm)	Result			
	(Vdc)	Hz	ppm	Limit (ppm)	Result			
QPSK								
25	4.35	98	0.038659	±2.5	Pass			
	3.80	65	0.025641					
	3.50	74	0.029191					
		16QAM						
25	4.35	80	0.031558	±2.5	Pass			
	3.80	96	0.037870					
	3.50	48	0.018935					
Note: Only the worst ca	se shown in the report.	_						



Report No: CCISE181005105

8 EUT Constructional Details

Reference to the test report No. CCISE181005101.

-----End of report-----